Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10648316	NAMIKATA, TAKESHI
Examiner	Art Unit
Yixing Qin	2625

SEARCHED					
Subclass	Date	Examiner			

SEARCH NOTES				
Search Notes	Date	Examiner		
updated searching for counterfeit detection systems	7/4/08	YQ		

INTERFERENCE SEARCH					
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